

# Yun Jung Jang

## List of Publications by Year in descending order

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Version: 2024-02-01

7  
papers

16  
citations

2682572

2  
h-index

2272923

4  
g-index

7  
all docs

7  
docs citations

7  
times ranked

50  
citing authors

#	ARTICLE	IF	CITATIONS
1	Comparison of quantitative analyses using SIMS, atom probe tomography, and femtosecond laser ablation inductively coupled plasma mass spectrometry with Si <sup>100</sup> XGeX and Fe <sup>100</sup> X NiX binary alloys. <i>Journal of Vacuum Science and Technology B: Nanotechnology and Microelectronics</i> , 2020, 38, .	1.2	0
2	Structural colors and physical properties of elytra in the jewel beetle, <i>Chrysochroa fulgidissima</i> , using surface analytical techniques. <i>Surface and Interface Analysis</i> , 2020, 52, 656-664.	1.8	3
3	ToF-SIMS and AFM Characterization of Brown Cosmetic Contact Lenses: From Structural Analysis to the Identification of Pigments. <i>Journal of Analytical Methods in Chemistry</i> , 2020, 2020, 1-11.	1.6	1
4	Complementary Characterization of Cu(In,Ga)Se <sub>2</sub> Thin-Film Photovoltaic Cells Using Secondary Ion Mass Spectrometry, Auger Electron Spectroscopy, and Atom Probe Tomography. <i>Journal of Nanoscience and Nanotechnology</i> , 2018, 18, 3548-3556.	0.9	1
5	Quantitative Analysis and Band Gap Determination for CIGS Absorber Layers Using Surface Techniques. <i>Journal of Analytical Methods in Chemistry</i> , 2018, 2018, 1-9.	1.6	8
6	Wear Characteristics of Fluorocarbon Thin Films Deposited Using Inductively Coupled and Capacitively Coupled Plasma Methods. <i>Journal of Nanoscience and Nanotechnology</i> , 2016, 16, 11480-11485.	0.9	1
7	Quantitative analysis for CIGS thin films by surface analytical techniques. <i>Surface and Interface Analysis</i> , 2014, 46, 276-280.	1.8	2